

<b>Notice of References Cited</b>	Application/Control No. 09/730,796	Applicant(s)/Patent Under Reexamination TSUKAMOTO ET AL.	
	Examiner Son P Huynh	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,006,257	12-1999	Slezak, Robert J.	725/110
	B	US-6,029,045	02-2000	Picco et al.	725/34
	C	US-6,282,713	08-2001	Kitsukawa et al.	725/36
	D	US-6,057,872	05-2000	Candelore, Brant	725/23
	E	US-5,532,735	07-1996	Blahut et al.	725/32
	F	US-5,861,881	01-1999	Freeman et al.	715/500.1
	G	US-6,282,293	08-2001	Itoh et al.	380/233
	H	US-6,020,912	02-2000	De Lang, Desiree	725/91
	I	US-5,610,653	03-1997	Abecassis, Max	348/170
	J	US-6,704,930	03-2004	Eldering et al.	725/36
	K	US-2003/0088872	05-2003	Maissel et al.	725/46
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.